

Search Notes

Application/Control No.

10/674,203

Examiner

John P. Sheehan

Applicant(s)/Patent under
Reexamination

DEARNALEY ET AL.

Art Unit

1742

SEARCHED

| Class | Subclass | Date | Examiner |
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INTERFERENCE SEARCHED

| Class | Subclass | Date | Examiner |
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**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

| | DATE | EXMR |
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| EAST | 2/6/2006 | JS |
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